TOSHIBA Photocoupler GaAs IRed & Photo-Triac

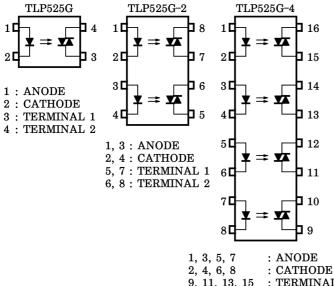
TLP525G,TLP525G-2,TLP525G-4

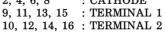
Triac Drive Programmable Controllers AC-Output Module Solid State Relay

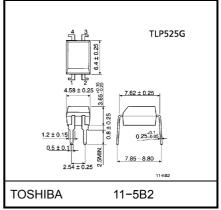
The TOSHIBA TLP525G, -2 and -4 consist of a photo-triac optically coupled to a gallium arsenide infrared emitting diode. The TLP525G-2 offers two isolated channels in an eight lead plastic DIP package, while the TLP525G-4 provides four isolated channels in a sixteenn lead plastic DIP package.

- Peak off-stage voltage: 400V (min.)
- Trigger LED current: 10mA (max.)
- Peak on-stage current: 2Apk (max.)
- Isolation voltage: 2500V_{rms} (min.)
- UL recognized: File no.E67349

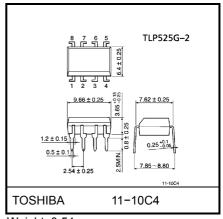
Pin Configurations (top view)



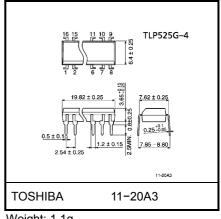




Weight: 0.26g



Weight: 0.54g



Weight: 1.1g

Maximum Ratings (Ta = 25°C)

Characteristic				Ra		
			Symbol	TLP525G	TLP525G–2 TLP525G–4	Unit
LED	Forward current		١ _F	50 50		mA
	Forward current derating		I _F / °C	-0.7 (Ta ≥ 53°C) -0.5 (Ta ≥ 25°C)		mA / °C
	Pulse forward current		I _{FP}	1 (100µs pulse, 100pps)		А
	Reverse voltage		V _R	5		V
	Junction temperature		Тj	125		°C
	Off–state output terminal voltage		V _{DRM}	400		V
	On-state RMS current	Ta = 25°C	I	100	80	mA
Detector		Ta = 70°C	I _{T (RMS)}	50	40	IIIA
	On–state current derating (Ta≥25°C)		I _T / °C	-1.1	-1.1 -0.9	
	Peak on state current		I _{TP}	2 (100µs pulse, 120pps)		А
	Peak nonrepetitive surge current (P _W = 10ms, DC = 10%)		I _{TSM}	1.2		А
	Junction temperature		Тj	115		°C
Storage temperature range			T _{stg}	-55~125		°C
Operating temperature range			T _{opr}	-40~100		°C
Lead soldering temperature			T _{sol}	260 (10s)		°C
Isolation voltage (Note)			BVS	2500 (AC, 1min., R.H. ≤ 60%)		V _{rms}

(Note) Device considered a two terminal device: LED side pins shorted together and detector side pins shorted together.

Recommended Operating Conditions

Characteristic	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V _{AC}	—	_	120	Vac
Forward current	١ _F	15	20	25	mA
Peak on-state current	I _{TP}	—	_	1	А
Operating temperature	T _{opr}	-25		85	°C

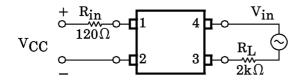
Individual Electrical Characteristics (Ta = 25°C)

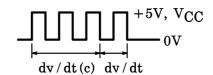
Characteristic		Symbol	Test Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	VF	I _F = 10mA	1.0	1.15	1.3	V
	Reverse current	I _R	V _R = 5V	_	_	10	μA
	Capacitance	CT	V = 0, f = 1MHz	_	30		pF
	Peak off-state current	I _{DRM}	V _{DRM} = 400V	_	10	100	nA
	Peak on-state voltage	V _{TM}	I _{TM} = 100mA	_	1.7	3.0	V
ctor	Holding current	Ι _Η	—	_	0.2		mA
Detector	Critical rate of rise of off–state voltage	dv / dt	V _{in} = 120V _{rms} , Ta = 85°C (Figure 1)	200	500		V / µs
	Critical rate of rise of commutating voltage	dv / dt (c)	V _{in} = 30V _{rms} , I _T = 15mA (Figure 1)	_	0.2		V / µs

Coupled Electrical Characteristics (Ta = 25°C)

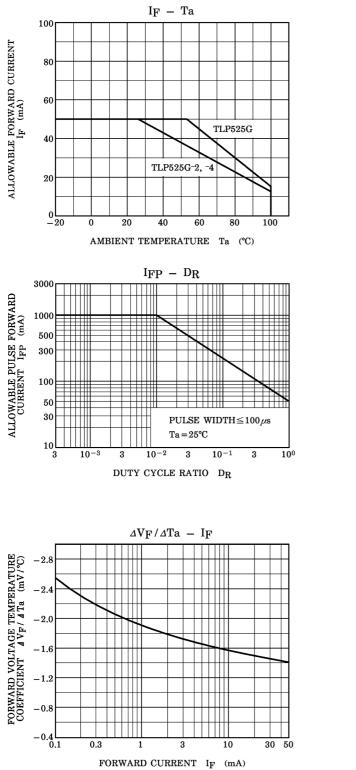
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Trigger LED current	I _{FT}	V _T = 3V	_	5	10	mA
Capacitance input to output	CS	V _S = 0, f = 1MHz	—	0.8	_	pF
Isolation resistance	R _S	V _S = 500V, R.H. ≤ 60%	5×10 ¹⁰	10 ¹⁴	_	Ω
	BVS	AC, 1 minute	2500	_	_	Vrms
Isolation voltage		AC, 1 second, in oil	—	5000	_	
		DC, 1 minute, in oil	—	5000	_	Vdc

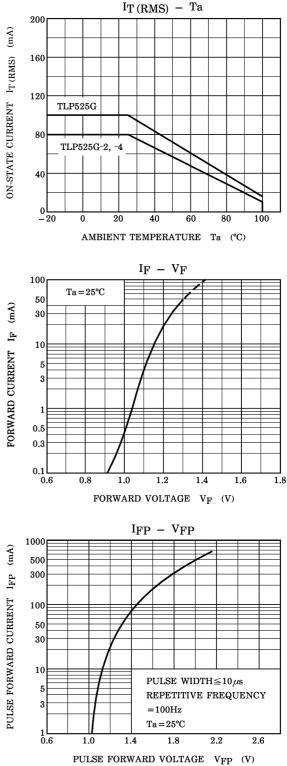
Fig.1 dv / dt Test Circuit

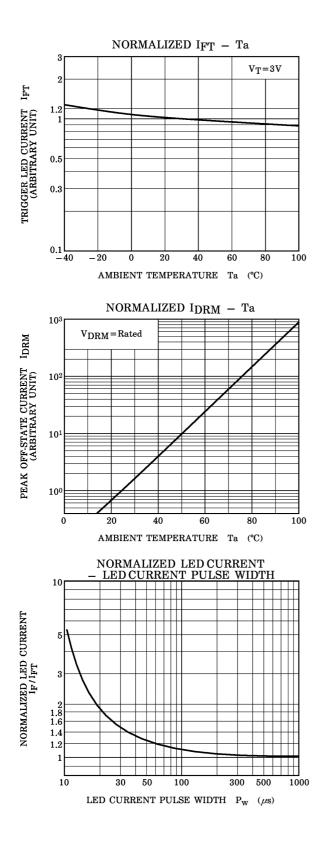


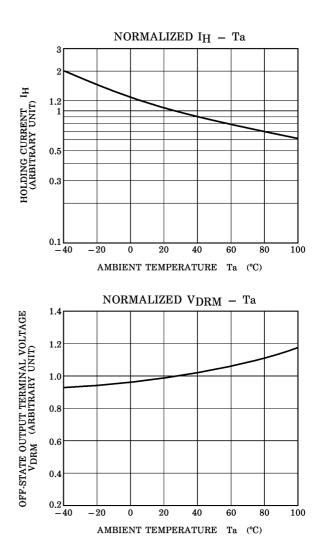


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